Application/Control No. Og/345,809 Examiner Christopher E. Lee Applicant(s)/Patent Under Reexamination CHRISTENSEN ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,445,905 B1	09-2002	Pentikainen, Jukka	455/8
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